

RF EXPOSURE Test Report

Product: Stand One (4th Gen)

Trade Mark: NOMAD

Model Number: NM014520858

FCC ID: 2AJYRNM014520858

Prepared for

Nomad Goods, Inc

1187 Coast Village Rd. #638, Santa Barbara, CA 93108, United States

Prepared by

Shenzhen HongBiao Certification& Testing Co., Ltd

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TEST RESULT CERTIFICATION

Applicant's Name : Nomad Goods, Inc
Address : 1187 Coast Village Rd. #638, Santa Barbara, CA 93108, United States
Manufacturer's Name : NuVolta Technologies (Hefei) Co., Ltd.
Address : Room 605/606, No.2800, Building F-1, Innovation Industrial Park Phase 2, Innovation Avenue, High-tech Zone, Hefei, Anhui, PRC.

Product description

Product name : Stand One (4th Gen)
Model Number : NM014520858

Standards : FCC CFR 47 PART 1 , 1.1310

Test procedure : KDB 680106 D01 Wireless Power Transfer v04

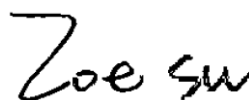
This device described above has been tested by Shenzhen HongBiao Certification& Testing Co., Ltd and the test results show that the equipment under test (EUT) is in compliance with the EMC requirements. And it is applicable only to the tested sample identified in the report.

Date of Test

Date (s) of performance of tests : May 13, 2025~ Sept. 01, 2025

Test Result..... : **Pass**

Testing Engineer :



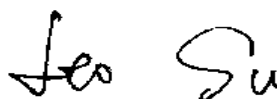
(Z o e S u)

Technical Manager :



(G a r y L u)

Authorized Signatory :



(L e o S u)

Revision History

[illegible]

1 General Description

1.1 Description of EUT

Product name:	Stand One (4th Gen)
Model name:	NM014520858
Series Model:	NM014513858
Different of series model:	All the models are the same circuit and module, except the colour.
Operation frequency:	Phone: 111-148kHz, 360kHz AirPods: 111-148kHz
Operational mode:	Wireless charging
Modulation type:	ASK
Antenna type:	Coil Antenna
Hardware version:	V1.0
Software version:	V1.0
Battery:	N/A
Power supply:	Input: 5V=3A, 9V=3A, 12V=3A, 15V=2.4A Wireless Output (Phone): 5W, 25W (Max) Wireless Output (AirPods): 5W
Adapter information:	N/A

1.2 Test Mode

Pretest Test Mode	Description of Mode
1	AC/DC adapter + Wireless Output (Phone: 5W+ AirPods: 5W)
2	AC/DC adapter + Wireless Output (Phone: 25W+ AirPods: 5W)

1.3 Test Setup

See photographs of the test setup in the report for the actual setup and connections between EUT and support equipment.

1.4 Ancillary Equipment

Equipment	Model	S/N	Manufacturer
Adapter	CD289	35810	Ugreen Group Limited
Phone	A1524	FK3NM1ME G5QY	Apple Inc.
Phone	LE2120	8602840564 41073	Shenzhen Oneplus Technology Co., Ltd
AirPods	A3057	GX8H9X0D5 3A0000B31	Apple Inc.

2 Test Facilities and Accreditations

2.1 Test Laboratory

Test Site	Shenzhen HongBiao Certification& Testing Co., Ltd
Test Site Location	Room 102, 201, Building 2, Yuanwanggu RFID Industrial Park, Tongguan Road, Tianliao Community, Yutang Street, Guangming District, Shenzhen, China
Telephone:	(86-755) 2998 9321
Fax:	(86-755) 2998 5110
FCC Registration No.:	CN1341
A2LA Certificate No.:	6765.01

2.2 Environmental Conditions

During the measurement the environmental conditions were within the listed ranges:

Temperature:	15°C~35°C
Relative Humidity:	20%~75%
Air Pressure:	98kPa~101kPa

2.3 Measurement Uncertainty

The reported uncertainty of measurement $y \pm U$, where expended uncertainty U is based on a standard uncertainty multiplied by a coverage factor of $k=2$, providing a level of confidence of approximately 95 %.

The data and results quoted in this document are true and accurate values, and uncertainties are not involved in the calculations.

In addition, components and mass production processes that are similar to testing equipment may introduce additional deviations, and the manufacturer is solely responsible for the continued compliance of the equipment.

Measurement Frequency Range	U, (dB)	Note
RF frequency	2×10^{-5}	
E-field	± 2.5 dB	
H-field	± 4.2 dB	
Temperature	± 1 degree	
Humidity	± 5 %	

2.4 Test Software

Software name	Manufacturer	Model	Version
EHP200-TS	Narda	EHP-200A	Rel 1.95

3 List of Test Equipment

Item	Equipment No.	Equipment name	Manufacturer	Model	Serial No.	Calibration date	Due date
1	HB-E073	Electric and Magnetic Field Analyzer	Narda	EHP-200A	180ZX11013	2025-05-10	2026-05-09

Note: the calibration interval of the above test instruments is 12 months and the calibrations are traceable to international system unit (SI).

4 RF Exposure

4.1 Maximum Permissible Exposure

4.1.1. Limit

Frequency range(MHz)	Electric field strength(V/m)	Magnetic field strength(A/m)	Power density(mW/cm2)	Averaging time(minutes)
(A) Limits for Occupational/Controlled Exposure				
0.3-3.0	614	1.63	*100	6
3.0-30	1842/f	4.89/f	*900/f ²	6
30-300	61.4	0.163	1.0 6	6
300-1500	/	/	f/300	6
1500-100000	/	/	5	6
(B) Limits for General Population/Uncontrolled Exposure				
0.3-1.34	614	1.63	*100	30
1.34-30	824/f	2.19/f	*180/f ²	30
30-300	27.5	0.073	0.2	30
300-1500	/	/	f/1500	30
1500-100000	/	/	1	30

f = frequency in MHz * = Plane-wave equivalent power density

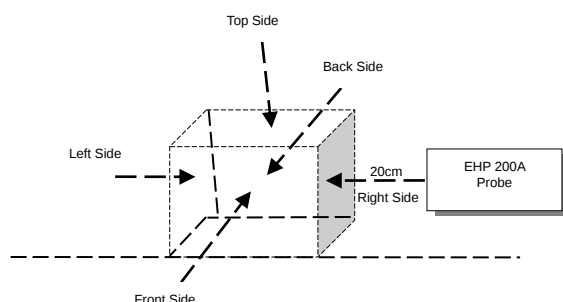
4.1.2. Test Procedures

E and H-field measurements should be made with the center of the probe at a distance of 20 cm surrounding the device and 20 cm above the top surface of the primary/client pair.

These measurements should be repeated for three different client battery levels, 1%, 50%, and 99%.

Record the test results.

4.1.3. Test Setup



4.1.4. Test Result

Test condition: Mode 1 operating mode with client device (1 %, 50%, 99% battery status of client device)

Maximum permissible Exposure				
Battery levels	Test sides	Test distance(cm)	E –field(V/m)	H–field(A/m)
<1%	Top	20	0.9846	0.0454
<1%	Left	20	0.9914	0.0454
<1%	Right	20	0.7160	0.0470
<1%	Front	20	0.8072	0.0440
<1%	Back	20	0.6181	0.0487
Limit			614	1.63
Margin Limit (%)			0.16%	2.99%

Maximum permissible Exposure				
Battery levels	Test sides	Test distance(cm)	E –field(V/m)	H–field(A/m)
<50%	Top	20	0.9836	0.0449
<50%	Left	20	0.9909	0.0447
<50%	Right	20	0.7158	0.0465
<50%	Front	20	0.8068	0.0434
<50%	Back	20	0.6175	0.0481
Limit			614	1.63
Margin Limit (%)			0.16%	2.95%

Maximum permissible Exposure				
Battery levels	Test sides	Test distance(cm)	E –field(V/m)	H–field(A/m)
<99%	Top	20	0.9832	0.0441
<99%	Left	20	0.9904	0.0442
<99%	Right	20	0.7151	0.0459
<99%	Front	20	0.8062	0.0428
<99%	Back	20	0.6169	0.0475
Limit			614	1.63
Margin Limit (%)			0.16%	2.91%

Test condition: Mode 2 operating mode with client device (1 %, 50%, 99% battery status of client device)

Maximum permissible Exposure				
Battery levels	Test sides	Test distance(cm)	E -field(V/m)	H-field(A/m)
<1%	Top	20	2.0134	0.0454
<1%	Left	20	1.4919	0.0454
<1%	Right	20	1.0133	0.0454
<1%	Front	20	1.9659	0.0456
<1%	Back	20	0.4948	0.0470
Limit			614	1.63
Margin Limit (%)			0.33%	2.88%

Maximum permissible Exposure				
Battery levels	Test sides	Test distance(cm)	E -field(V/m)	H-field(A/m)
<50%	Top	20	2.0129	0.0448
<50%	Left	20	1.4914	0.0449
<50%	Right	20	1.0125	0.0442
<50%	Front	20	1.9651	0.0443
<50%	Back	20	0.4944	0.0463
Limit			614	1.63
Margin Limit (%)			0.33%	2.84%

Maximum permissible Exposure				
Battery levels	Test sides	Test distance(cm)	E -field(V/m)	H-field(A/m)
<99%	Top	20	2.0124	0.0439
<99%	Left	20	1.4908	0.0441
<99%	Right	20	1.0121	0.0435
<99%	Front	20	1.9645	0.0436
<99%	Back	20	0.4936	0.0458
Limit			614	1.63
Margin Limit (%)			0.33%	2.81%

5 Photographs of the Test Setup

See the Appendix – Test Setup Photos.

******* END OF REPORT *******